## NLAS3257

## Mux / Demux Analog Switch

The NLAS3257 Mux / Demux Analog Switch is an advanced high-speed single pole double throw (SPDT) analog switch in ultra-small footprint.

## Features

- High Speed: $\mathrm{t}_{\mathrm{PD}}=0.25 \mathrm{~ns}(\mathrm{Max}) @ \mathrm{~V}_{\mathrm{CC}}=4.5 \mathrm{~V}$
- $\mathrm{R}_{\mathrm{ON}}: 7.5 \Omega$, Typ @ $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$
- $\mathrm{C}_{\mathrm{ON}}: 7.5 \mathrm{pF}$, Typ @ $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$
- $\mathrm{V}_{\mathrm{CC}}$ Range: 1.65 V to 4.5 V
- Ultra-Small $1 \times 1$ mm Package
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free/BFR Free and are RoHS Compliant


## Typical Applications

- Mobile Phones, PDAs, Camera


Figure 1. XLLGA6 (Top View)


Figure 2. Logic Diagram

Function Table

| Input S | Function |
| :---: | :---: |
| L | $\mathrm{A}=\mathrm{B} 0$ |
| H | $\mathrm{A}=\mathrm{B} 1$ |

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www.onsemi.com

| er |  |  | MARKING DIAGRAM |
| :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} \text { XLLGA6 } \\ 1.0 \times 1.0 \\ \text { CASE } 713 A D \end{gathered}$ | - LM |
|  | L | = Specific Device Code <br> = Date Code |  |

ORDERING INFORMATION
See detailed ordering and shipping information on page 6 of this data sheet.

NLAS3257

Table 1. MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC Supply Voltage | -0.5 to +5.5 | V |
| $\mathrm{V}_{\text {IN }}$ | Control Input Voltage (S Pin) | -0.5 to +5.5 | V |
| $\mathrm{V}_{1 / \mathrm{O}}$ | Switch Input / Output Voltage (A, B0, B1 Pins) | -0.5 to +5.5 | $\checkmark$ |
| IK | Control Pin DC Input Diode Current (S Pin) $\mathrm{V}_{\text {IN }}<$ GND | -50 | mA |
| lok | Switch I/O Port DC Diode Current (A, B0, B1 Pins) $\quad \mathrm{V}_{\text {I/O }}<$ GND or $\mathrm{V}_{\text {I/O }}>\mathrm{V}_{\mathrm{CC}}$ | $\pm 50$ | mA |
| Io | On-State Switch Current | $\pm 128$ | mA |
|  | Continuous Current Through V $\mathrm{CC}^{\text {or GND }}$ | $\pm 150$ | mA |
| ICC | DC Supply Current per Supply Pin | $\pm 150$ | mA |
| $\mathrm{I}_{\text {GND }}$ | DC Ground Current per Ground Pin | $\pm 150$ | mA |
| $\mathrm{T}_{\text {STG }}$ | Storage Temperature Range | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| TL | Lead Temperature, 1 mm from Case for 10 Seconds | 260 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{J}$ | Junction Temperature Under Bias | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Note 1) XLLGA6 | 466 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation in Still Air at $85^{\circ} \mathrm{C}$ (Note 1) XLLGA6 | 269 | mW |
| MSL | Moisture Sensitivity | Level 1 |  |
| $\mathrm{F}_{\mathrm{R}}$ | Flammability Rating Oxygen Index: 28 to 34 | UL 94 V-0 @ 0.125 in |  |
| $\mathrm{V}_{\text {ESD }}$ | ESD Withstand VoltageHuman Body Mode (Note 2) <br> Machine Mode (Note 3) <br> Charged Device Mode (Note 4) | $\begin{gathered} >6000 \\ >200 \\ \text { N/A } \end{gathered}$ | V |
| ILATCHUP | Latchup Performance Above $\mathrm{V}_{\text {CC }}$ and Below GND at $85^{\circ} \mathrm{C}$ (Note 5) | $\pm 100$ | mA |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Measured with minimum pad spacing on an FR4 board, using 10 mm -by-1 inch, 2 ounce copper trace no air flow.
2. Tested to EIA/ JESD22-A114-A
3. Tested to EIA/ JESD22-A115-A
4. Tested to JESD22-C101-A
5. Tested to EIA / JESD78.

Table 2. RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Positive DC Supply Voltage | 1.65 | 4.5 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | Control Pin Input Voltage (S Pin) | 0 | 4.5 | V |
| $\mathrm{~V}_{1 / \mathrm{O}}$ | Switch Input / Output Voltage (A, B0, B1 Pins) | 0 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Free-Air Temperature | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |
| $\Delta \mathrm{t} / \Delta \mathrm{V}$ | Input Transition Rise or Fall Rate | Control Input <br> Switch $/ \mathrm{O}$ | 0 <br> 0 | 20 <br> DC |

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 3. DC ELECTRICAL CHARACTERISTICS (Typical: $\mathrm{T}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ )

| Symbol | Parameter | Test Conditions | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Typ | Max |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Control Input, High Voltage (S Pin) |  | $\begin{aligned} & 2.7 \\ & 3.3 \\ & 4.2 \end{aligned}$ | $\begin{aligned} & 0.8 \\ & 1.0 \\ & 1.25 \end{aligned}$ |  |  | V |
| $\mathrm{V}_{\text {IL }}$ | Control Input, Low Voltage (S Pin) |  | $\begin{aligned} & 2.7 \\ & 3.3 \\ & 4.2 \end{aligned}$ |  |  | $\begin{aligned} & \hline 0.3 \\ & 0.4 \\ & 0.5 \end{aligned}$ | V |
| $\mathrm{I}_{\mathrm{IN}}$ | Control Input, Leakage Current (S Pin) | $0 \leq \mathrm{V}_{\text {IN }} \leq \mathrm{V}_{\mathrm{CC}}$ | 1.65-4.5 |  | $\pm 0.5$ | $\pm 1.0$ | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {B0/B1_OFF }}$ | Off State Leakage Current (B0/B1 Pins) | $\begin{gathered} \mathrm{V}_{I N}=\mathrm{V}_{\mathrm{IL}} \text { or } \mathrm{V}_{\mathrm{IH}} \\ \mathrm{~V}_{\mathrm{BO}} \text { and } \mathrm{V}_{\mathrm{B} 1}=0.3 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{A}}=4 \mathrm{~V} \end{gathered}$ | 4.5 |  | $\pm 20$ | $\pm 100$ | nA |
| $\mathrm{I}_{\text {A_ON }}$ | On State Leakage Current (A Pin) | $\begin{gathered} \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{IL}} \text { or } \mathrm{V}_{\mathrm{IH}} \\ \mathrm{~V}_{\mathrm{B} 0}=0.3 \mathrm{~V} \text { or } 4 \mathrm{~V} \text { with } \\ \mathrm{V}_{\mathrm{B} 1}=\text { Floating } \\ \text { or } \\ \mathrm{V}_{\mathrm{B} 1}=0.3 \mathrm{~V} \text { or } 4 \mathrm{~V} \text { with } \\ \mathrm{V}_{\mathrm{B} 0}=\text { Floating } \\ \mathrm{V}_{\mathrm{A}}=0.3 \mathrm{~V} \text { or } 4.0 \mathrm{~V} \end{gathered}$ | 4.5 |  | $\pm 20$ | $\pm 100$ | nA |
| IPower_OFF | Power Off Leakage Current (S Pin) | $\mathrm{V}_{\mathrm{IN}}=0$ or 4.5 V | 0 |  |  | $\pm 100$ | nA |
| Icc | Quiescent Supply Current ( $\mathrm{V}_{\mathrm{CC}} \mathrm{Pin}$ ) | $\begin{aligned} & V_{I N}=V_{C C} \text { or } G N D, \\ & V_{I S}=V_{C C} \text { or } G N D, \\ & I_{\text {Load }}=0 \mathrm{~A} \end{aligned}$ | 1.65-4.5 |  | 0.1 | 1.0 | $\mu \mathrm{A}$ |
| $\Delta \mathrm{I}_{\text {CC }}$ | Additional Quiescent Supply Current (VCC Pin) | $\begin{gathered} \mathrm{V}_{I N}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND}, \\ \mathrm{~V}_{I S}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND}, \\ \mathrm{I}_{\text {Load }}=0 \mathrm{~A} \end{gathered}$ | $\begin{aligned} & \hline 3.3 \\ & 4.2 \end{aligned}$ |  |  | $\begin{aligned} & 2.0 \\ & 3.0 \end{aligned}$ | mA |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Table 4. ON RESISTANCE (Typical: $\mathrm{T}=25^{\circ} \mathrm{C}$ )

| Symbol | Parameter | Test Conditions | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Typ | Max |  |
| RON | ON-Resistance | $\begin{gathered} \mathrm{ION}=8 \mathrm{~mA}, \\ \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{CC}} \end{gathered}$ | $\begin{aligned} & 2.7 \\ & 3.3 \\ & 4.2 \end{aligned}$ |  | $\begin{aligned} & 9.3 \\ & 8.7 \\ & 7.5 \end{aligned}$ |  | $\Omega$ |
| RFLAT | ON-Resistance Flatness | $\begin{gathered} \mathrm{ION}=8 \mathrm{~mA}, \\ \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{CC}} \end{gathered}$ | $\begin{aligned} & 2.7 \\ & 3.3 \\ & 4.2 \end{aligned}$ |  | $\begin{aligned} & \hline 3.6 \\ & 3.3 \\ & 2.9 \end{aligned}$ |  | $\Omega$ |
| $\Delta \mathrm{R}_{\mathrm{ON}}$ | Delta ON- Resistance | $\begin{gathered} \mathrm{ION}=8 \mathrm{~mA}, \\ \mathrm{~V}_{\text {IS }}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{CC}} \end{gathered}$ | $\begin{aligned} & 2.7 \\ & 3.3 \\ & 4.2 \end{aligned}$ |  | $\begin{aligned} & 0.8 \\ & 0.7 \\ & 0.5 \end{aligned}$ |  | $\Omega$ |

## AC ELECTRICAL CHARACTERISTICS

Table 5. TIMING/FREQUENCY (Typical: $\mathrm{T}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}, \mathrm{f}=1 \mathrm{MHz}$ )

| Symbol | Parameter | Test Condition | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Typ | Max |  |
| $t_{\text {PD }}$ | Propagation Delay, A to Bn or Bn to A |  | 1.65-4.5 |  |  | 0.25 | ns |
| ton | Turn-ON Time | (See Figures 4 and 5) | 1.65-4.5 |  | 12 | 30 | ns |
| toff | Turn-OFF Time | (See Figures 4 and 5) | 1.65-4.5 |  | 8.0 | 25 | ns |
| $\mathrm{t}_{\text {BBM }}$ | Break-Before-Make Time | (See Figure 3) | 1.65-4.5 | 2.0 |  |  | ns |
| BW | -3 dB Bandwidth | $\mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ | 1.65-4.5 |  | 900 |  | MHz |

Table 6. ISOLATION (Typical: $T=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ )

| Symbol | Parameter | Test Condition | $\mathrm{V}_{\mathrm{cc}}$ (V) | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Typ | Max |  |
| OIRR | OFF-Isolation | $\mathrm{f}=240 \mathrm{MHz}$ <br> (See Figure 6) | 1.65-4.5 |  | -21 |  | dB |
| $\mathrm{X}_{\text {TALK }}$ | Non-Adjacent Channel Crosstalk | $\mathrm{f}=240 \mathrm{MHz}$ | 1.65-4.5 |  | -21 |  | dB |

Table 7. CAPACITANCE (Typical: $\mathrm{T}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ )

| Symbol | Parameter | Test Condition | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| $\mathrm{C}_{\text {IN }}$ | Control Input Capacitance | S pin |  |  | 2.0 | pF |
| $\mathrm{Con}^{\text {a }}$ | ON Capacitance | $\begin{aligned} & \text { Switch ON } \\ & \text { A to B0 } \\ & \text { A to B1 } \end{aligned}$ |  |  | 7.5 | pF |
| CofF | OFF Capacitance | Switch OFF B0 OFF B1 OFF |  |  | 2.5 | pF |



Figure 3. $\mathrm{t}_{\mathrm{BBM}}$ (Time Break-Before-Make)


Figure 4. $\mathrm{t}_{\mathrm{ON}} / \mathrm{t}_{\mathrm{OFF}}$


Figure 5. $\mathrm{t}_{\mathrm{ON}} / \mathrm{t}_{\mathrm{OFF}}$


Channel switch control/s test socket is normalized. Off isolation is measured across an off channel. On loss is the bandwidth of an On switch. $\mathrm{V}_{\text {ISO }}$, Bandwidth and $\mathrm{V}_{\text {ONL }}$ are independent of the input signal direction.
$\mathrm{V}_{\text {ISO }}=$ Off Channel Isolation $=20 \log \left(\frac{\mathrm{~V}_{\text {OUT }}}{\mathrm{V}_{\text {IN }}}\right)$ for $\mathrm{V}_{\text {IN }}$ at 100 kHz
$\mathrm{V}_{\mathrm{ONL}}=$ On Channel Loss $=20 \log \left(\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{VIN}}\right)$ for $\mathrm{V}_{\text {IN }}$ at 100 kHz to 50 MHz
Bandwidth (BW) = the frequency 3 dB below $\mathrm{V}_{\mathrm{ONL}}$
$\mathrm{V}_{\mathrm{CT}}=$ Use $\mathrm{V}_{\text {ISO }}$ setup and test to all other switch analog input/outputs terminated with $50 \Omega$

Figure 6. Off Channel Isolation/On Channel Loss (BW)/Crosstalk (On Channel to Off Channel)/V ${ }_{\text {ONL }}$

DEVICE ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :--- | :---: | :---: |
| NLAS3257CMX2TCG | XLLGA6 <br> (Pb-Free) |  |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

XLLGA6 1.0x1.0, 0.35P
CASE 713AD
ISSUE O


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
CONTROLLING DIMENSION: MILLIMETERS.
2. DIMENSION b APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.25 MM AND IS MEASURED BETIES
3. COPLANARITY APPLIES TO ALL OF THE TERMINALS.
4. COPLANARITY APPLIES

|  | MILLIMETERS |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX |  |  |
| A | -- | 0.40 |  |  |
| A1 | 0.00 | 0.05 |  |  |
| b | 0.17 | 0.23 |  |  |
| D | 1.00 | BSC |  |  |
| E | 1.00 |  |  |  |
| BSC |  |  |  |  |
| e | 0.35 |  |  |  |
| BSC |  |  |  |  |
| e2 | 0.60 |  |  | BSC |
| L | 0.27 | 0.33 |  |  |
| L1 | 0.05 |  |  | REF |


*For additional information on our $\mathrm{Pb}-$ Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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